

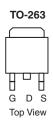
SUB85N10-10-GE3-VB Datasheet N-Channel 100-V (D-S) MOSFET

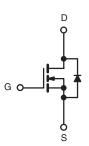
PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)		
100	0.010 at V _{GS} = 10 V	100		
	0.023 at V _{GS} = 4.5 V	85		

FEATURES

- TrenchFET® Power MOSFET
- 175 °C Maximum Junction Temperature
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted					
Parameter			Limit	Unit	
Drain-Source Voltage		V_{DS}	100	· ·	
Gate-Source Voltage			± 20	V	
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C	. I _D	100		
	T _C = 125 °C		75 ^a		
Pulsed Drain Current		I _{DM}	300	Α	
Avalanche Current	L = 0.1 mH	I _{AS}	75		
Single Pulse Avalanche Energy ^b	L = 0.1 IIII I	E _{AS}	280	mJ	
Maximum Power Dissipation ^b	T _C = 25 °C (TO-220AB and TO-263)	P _D	250 ^c	W	
	T _A = 25 °C (TO-263) ^d	٠ ٥	3.75		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Limit	Unit	
Junction-to-Ambient	PCB Mount (TO-263) ^d	- R _{thJA}	40	°C/W	
Junction-to-Ambient	Free Air (TO-220AB)	' 'thJA	62.5		
Junction-to-Case		R _{thJC}	0.6		

Notes:

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			•				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2		4		
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
		V _{DS} = 100 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V, T _J = 125 °C			50	μΑ	
		V _{DS} = 100 V, V _{GS} = 0 V, T _J = 175 °C			250		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	120			Α	
		$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$		0.010			
	B	$V{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.023		Ω	
Drain-Source On-State Resistance ^a	H _{DS(on)}	V _{GS} = 10 V, I _D = 30 A, T _J = 125 °C		0.020			
		V _{GS} = 10 V, I _D = 30 A, T _J = 175 °C		0.030			
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_{D} = 30 \text{ A}$	25			S	
Dynamic ^b							
Input Capacitance	C _{iss}			6550			
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$		665		pF	
Reverse Transfer Capacitance	C _{rss}]		265			
Total Gate Charge ^c	Q_g			105	160		
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 85 \text{ A}$		17		nC	
Gate-Drain Charge ^c	Q_{gd}	7		23			
Turn-On Delay Time ^c	t _{d(on)}			12	25		
Rise Time ^c	t _r	$V_{DD} = 50 \text{ V}, R_{L} = 0.6 \Omega$		90	135		
Turn-Off DelayTime ^c	t _{d(off)}	$I_D\cong 85~A,~V_{GEN}=10~V,~R_g=2.5~\Omega$		55	85	ns	
Fall Time ^c	t _f	7		130	195	7	
Source-Drain Diode Ratings and Cha	acteristics T _C	= 25 °C ^b					
Continuous Current	I _S				85	Λ	
Pulsed Current	I _{SM}				240	A	
Forward Voltage ^a	V _{SD}	I _F = 85 A, V _{GS} = 0 V		1.0	1.5	V	
Reverse Recovery Time	t _{rr}			85	140	ns	
Peak Reverse Recovery Current	I _{RM(REC)}	I _F = 50 A, dI/dt = 100 A/μs		4.5	7	Α	
Reverse Recovery Charge	Q _{rr}	1		0.17	0.35	μC	

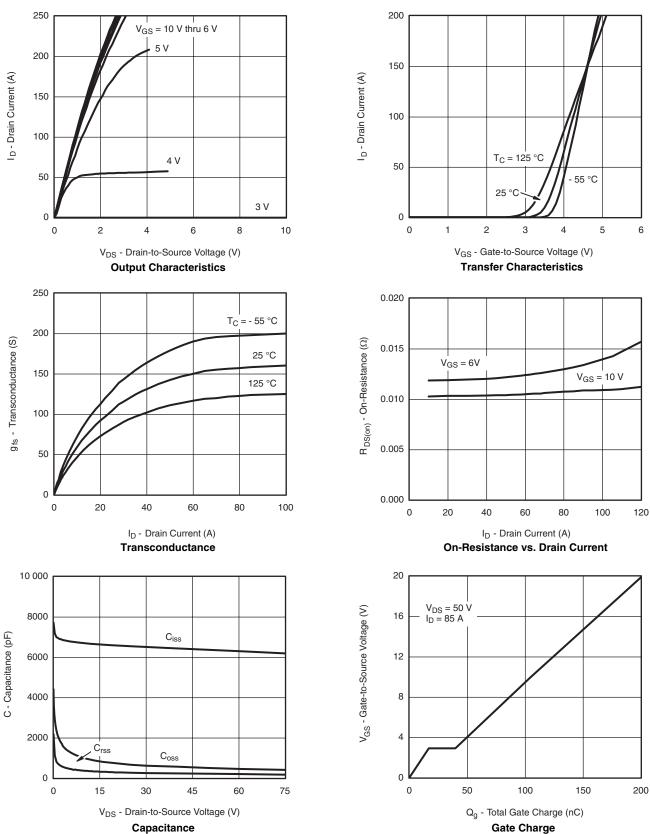
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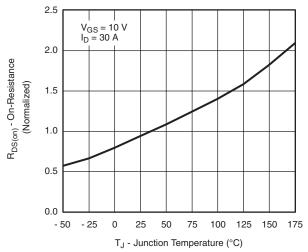


TYPICAL CHARACTERISTICS $T_A = 25 \, ^{\circ}C$, unless otherwise noted

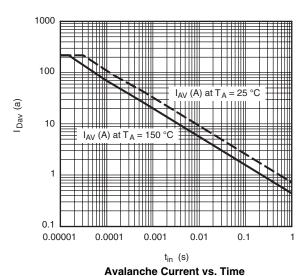




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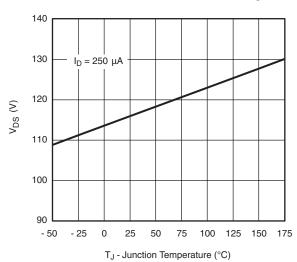


On-Resistance vs. Junction Temperature



T_J = 150 °C T_J = 25 °C T_J

Source-Drain Diode Forward Voltage

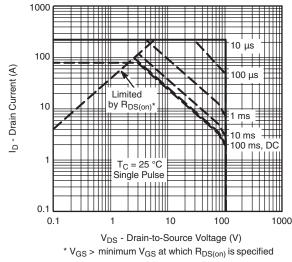


T_J - Drain-Source Breakdown vs. Junction-Temperature

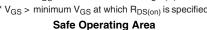


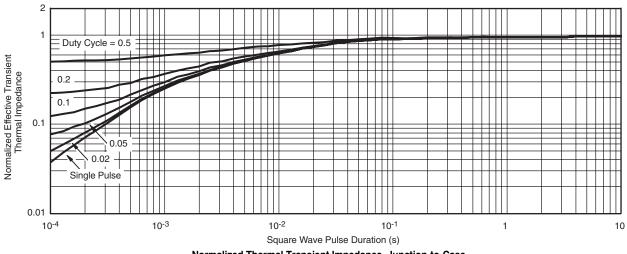
THERMAL RATINGS





Maximum Avalanche and Drain Current vs. Case Temperature





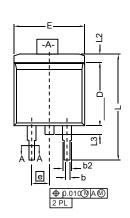
Normalized Thermal Transient Impedance, Junction-to-Case

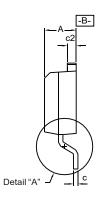
服务热线:400-655-8788

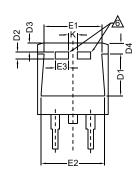
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TO-263 (D²PAK): 3-LEAD

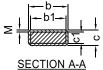








DETAIL A (ROTATED 90°)



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Notes

- 1. Plane B includes maximum features of heat sink tab and plastic.
- 2. No more than 25 % of L1 can fall above seating plane by $\;$ max. 8 mils.
- 3. Pin-to-pin coplanarity max. 4 mils.
- 4. *: Thin lead is for SUB, SYB.
 Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

 This feature is for thick lead.

INCHES		MILLIMETERS		
DIM.	MIN.	MAX.	MIN.	MAX.
Α	0.160	0.190	4.064	4.826
b	0.020	0.039	0.508	0.990
b1	0.020	0.035	0.508	0.889
b2	0.045	0.055	1.143	1.397
Thin lead	0.013	0.018	0.330	0.457
Thick lead	0.023	0.028	0.584	0.711
Thin lead	0.013	0.017	0.330	0.431
Thick lead	0.023	0.027	0.584	0.685
c2	0.045	0.055	1.143	1.397
D	0.340	0.380	8.636	9.652
D1	0.220	0.240	5.588	6.096
D2	0.038	0.042	0.965	1.067
D3	0.045	0.055	1.143	1.397
D4	0.044	0.052	1.118	1.321
E	0.380	0.410	9.652	10.414
E1	0.245	-	6.223	-
E2	0.355	0.375	9.017	9.525
E3	0.072	0.078	1.829	1.981
е	0.100 BSC		2.54 BSC	
K	0.045	0.055	1.143	1.397
L	0.575	0.625	14.605	15.875
L1	0.090	0.110	2.286	2.794
L2	0.040	0.055	1.016	1.397
L3	0.050	0.070	1.270	1.778
L4	0.010	0 BSC 0.254 BSC		BSC
M	-	0.002	-	0.050
	A b b1 b2 Thin lead Thick lead Thick lead c2 D D1 D2 D3 D4 E E1 E2 E3 e K L L1 L2 L3 L4 M	DIM. MIN. A 0.160 b 0.020 b1 0.020 b2 0.045 Thin lead 0.013 Thick lead 0.023 Thin lead 0.023 c2 0.045 D 0.340 D1 0.220 D2 0.038 D3 0.045 D4 0.044 E 0.380 E1 0.245 E2 0.355 E3 0.072 e 0.100 K 0.045 L 0.575 L1 0.090 L2 0.040 L3 0.050 L4 0.010	DIM. MIN. MAX. A 0.160 0.190 b 0.020 0.039 b1 0.020 0.035 b2 0.045 0.055 Thin lead 0.013 0.018 Thick lead 0.023 0.028 Thin lead 0.013 0.017 Thick lead 0.023 0.027 c2 0.045 0.055 D 0.340 0.380 D1 0.220 0.240 D2 0.038 0.042 D3 0.045 0.055 D4 0.044 0.052 E 0.380 0.410 E1 0.245 - E2 0.355 0.375 E3 0.072 0.078 e 0.100 BSC K 0.045 0.055 L 0.575 0.625 L1 0.090 0.110 L2 0.040 0.055	DIM. MIN. MAX. MIN. A 0.160 0.190 4.064 b 0.020 0.039 0.508 b1 0.020 0.035 0.508 b2 0.045 0.055 1.143 Thin lead 0.013 0.018 0.330 Thick lead 0.023 0.028 0.584 Thin lead 0.013 0.017 0.330 Thick lead 0.023 0.027 0.584 c2 0.045 0.055 1.143 D 0.340 0.380 8.636 D1 0.220 0.240 5.588 D2 0.038 0.042 0.965 D3 0.045 0.055 1.143 D4 0.044 0.052 1.118 E 0.380 0.410 9.652 E1 0.245 - 6.223 E2 0.355 0.375 9.017 E3 0.072 0.078

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